Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/875,364	LEE ET AL.	
Examiner	Art Unit	
Khanh Tran	2631	

	SEAR	CHED	
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375	257,259, 285,355, 356,362, 371	4/29/2005	кст
370	503,508		
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Inventor Name Search		
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